



RADIO TEST REPORT

Test Report No. : 30FE0017-HO-01-A-R2

Applicant : Maxell Seiki, Ltd.
Type of Equipment : RFID UNIT
Model No. : COBAS-Reader 8000
Test standard : FCC Part 15 Subpart C : 2009
Section 15.207 and 15.225
FCC ID : UOE-0015573942
Test Result : Complied

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6. This report is a revised version of 30FE0017-HO-01-A-R1. 30FE0017-HO-01-A-R1 is replaced with this report.

Date of test: January 12 to February 11, 2010

Tested by:


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NVLAP LAB CODE: 200572-0

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SECTION 1: Customer information

Company Name : Maxell Seiki, Ltd.
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SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment : RFID UNIT
Model No. : COBAS-Reader 8000
Serial No. : Refer to Clause 4.2
Rating : DC 5.0V
Receipt Date of Sample : January 12, 2010
Country of Mass-production : Japan
Condition of EUT : Production prototype
(Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT : No Modification by the test lab

2.2 Product Description

Model No: COBAS-Reader 8000 is the RFID UNIT.
The EUT has two types of models, with and without ferrite core.

Refer to the following:

[Without ferrite core]

Antenna Switching PWB	4ch type	8ch type
The Number of Antennas	1-4	1-8
Model No.	COBAS-Reader 8000	COBAS-Reader 8000

[With ferrite core]

Antenna Switching PWB	4ch type	8ch type
The Number of Antennas	1-4	1-8
Model No.	COBAS-Reader	COBAS-Reader

The clock frequency of EUT is 13.56MHz (RF) and 10MHz (CPU).

Equipment Type : Transceiver
Frequency of Operation : 13.56MHz
Type of Modulation : ASK
Antenna Type : LOOP ANTENNA
Antenna connector Type : PH CONNECTOR (MAKER: JST)
Method of Frequency Generation : Crystal
Power Supply : DC 5.0V
Operating Temperature : 0 deg. C. to +55 deg. C.

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SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification : FCC Part15 Subpart C: 2009, final revised on December 2, 2009

Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators
Section 15.207 Conducted limits
Section 15.225 : Operation within the band 13.110-14.010MHz

3.2 Procedures and results

Item	Test Procedure	Specification	Worst margin	Results	Remarks
Conducted emission	ANSI C63.4:2003 7. AC powerline conducted emission measurements ----- <IC>RSS-Gen 7.2.2	Section 15.207 ----- <IC>RSS-Gen 7.2.2	[QP] 9.0dB 13.56000MHz, N With Tag, 8ch type [AV] 0.9dB 13.56000MHz, N With Tag, 8ch type	Complied	-
Electric Field Strength of Fundamental Emission	ANSI C63.4:2003 13. Measurement of intentional radiators ----- <IC> RSS-Gen 4.8, 4.11	Section 15.225(a) ----- <IC>RSS-210 A2.6	67.1dB 13.56000MHz QP, 90deg. Without Tag, 4ch type	Complied	Radiated
Spectrum Mask	ANSI C63.4:2003 13. Measurement of intentional radiators ----- <IC>RSS-Gen 4.9, 4.11	Section 15.225(b)(c) ----- <IC> RSS-210 A2.6	44.6dB 13.55300MHz QP, 90deg. Without Tag, 4ch type	Complied	Radiated
20dB Bandwidth	ANSI C63.4:2003 13. Measurement of intentional radiators ----- <IC> -	Section15.215(c) ----- <IC> -	See data	Complied	Radiated
Electric Field Strength of Spurious Emission	ANSI C63.4:2003 13. Measurement of intentional radiators ----- <IC>RSS-Gen 4.9, 4.11	Section15.209, Section 15.225 (d) ----- <IC>RSS-210 A2.6	3.2dB 266.445MHz QP, Horizontal With Tag, 4ch type	Complied	Radiated
Frequency Tolerance	ANSI C63.4:2003 13. Measurement of intentional radiators ----- <IC>RSS-Gen 4.7	Section15.225(e) ----- <IC> RSS-210 A2.6	See data	Complied	Radiated

Note: UL Japan, Inc.'s EMI Work Procedures No.QPM05 and QPM15

FCC 15.31 (e)

This EUT provides stable voltage (DC5.0V) constantly to RF Module regardless of input voltage. Therefore, this EUT complies with the requirement.

FCC Part 15.203/212 Antenna requirement

The EUT has a unique coupling/antenna connector (PH connector). Therefore the equipment complies with the requirement of 15.203.

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3.3 Addition to standard

Item	Test Procedure	Specification	Worst margin	Results	Remarks
99% Occupied Band Width	RSS-Gen 4.6.1	RSS-Gen 4.6.1	N/A	N/A	Radiated

Other than above, no addition, exclusion nor deviation has been made from the standard.

3.4 Uncertainty

EMI

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

Test room (semi-anechoic chamber)	Conducted emission (+dB)
	150kHz-30MHz
No.1	2.6dB
No.2	2.9dB
No.3	3.3dB
No.4	2.8dB

Test room (semi-anechoic chamber)	Radiated emission (10m*)(±dB)			Radiated emission					
				(3m*)(±dB)					(1m*)(±dB)
	9kHz -30MHz	30MHz -300MHz	300MHz -1GHz	9kHz -30MHz	30MHz -300MHz	300MHz -1GHz	1GHz -18GHz	18GHz -26.5GHz	26.5GHz -40GHz
No.1	2.7dB	4.8dB	5.0dB	2.9dB	4.8dB	5.0dB	3.9dB	4.5dB	4.4dB
No.2	-	-	-	3.5dB	4.8dB	5.1dB	4.0dB	4.3dB	4.2dB
No.3	-	-	-	3.8dB	4.6dB	4.7dB	4.0dB	4.5dB	4.4dB
No.4	-	-	-	3.5dB	4.4dB	4.9dB	4.0dB	4.6dB	4.5dB

*10m/3m/1m = Measurement distance

Frequency counter (+)	
Normal condition	Extreme condition
7×10^{-6}	9×10^{-6}

Conducted emission test

The data listed in this report meets the limits unless the uncertainty is taken into consideration.

Radiated emission test(3m)

The data listed in this report meets the limits unless the uncertainty is taken into consideration.

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3.5 Test Location

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	FCC Registration Number	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms
No.1 semi-anechoic chamber	313583	2973C-1	19.2 x 11.2 x 7.7m	7.0 x 6.0m	No.1 Power source room
No.2 semi-anechoic chamber	655103	2973C-2	7.5 x 5.8 x 5.2m	4.0 x 4.0m	-
No.3 semi-anechoic chamber	148738	2973C-3	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.3 Preparation room
No.3 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.4 semi-anechoic chamber	134570	2973C-4	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.4 Preparation room
No.4 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.5 semi-anechoic chamber	-	-	6.0 x 6.0 x 3.9m	6.0 x 6.0m	-
No.6 shielded room	-	-	4.0 x 4.5 x 2.7m	4.75 x 5.4 m	-
No.6 measurement room	-	-	4.75 x 5.4 x 3.0m	4.75 x 4.15 m	-
No.7 shielded room	-	-	4.7 x 7.5 x 2.7m	4.7 x 7.5m	-
No.8 measurement room	-	-	3.1 x 5.0 x 2.7m	N/A	-
No.9 measurement room	-	-	8.0 x 4.5 x 2.8m	2.0 x 2.0m	-
No.10 measurement room	-	-	2.6 x 2.8 x 2.5m	2.4 x 2.4m	-
No.11 measurement room	-	-	3.1 x 3.4 x 3.0m	2.4 x 3.4m	-

* Size of vertical conducting plane (for Conducted Emission test) : 2.0 x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test set up, Data of EMI, and Test instruments

Refer to APPENDIX .

SECTION 4: Operation of E.U.T. during testing

4.1 Operating Modes

The mode is used :

Mode	Remarks*
Communication mode (Tx)	With Tag
	Without Tag
	Antenna terminated with dummy load
<p>*The EUT was operated in a manner similar to typical use during the tests.</p> <p>*The EUT Transmits and Receives at the same time and there is no receiving mode.</p> <p>*The EUT does not have a simultaneous transmission function.</p> <p>*There is no difference for all of the antenna specification.</p> <p>*The EUT has two types of models, with and without ferrite core.</p> <p>The test was performed with a model without ferrite core as a representative since a model without ferrite core had had the worst level in pre-check.</p> <p>-Software details; Production company: Takaya Corporation Product name: RF-ID Monitor soft Version: 1.5.5.0</p> <p><Major function used at the test> * Continuous Tag communication ON/OFF * Modulation ON/OFF * Ch selection</p> <p>This software does not have a Power Control function. The test was performed with Default value written on RF module ROM. Mass-produced product will have same level as it.</p>	

Test Item	Operating mode*
Conducted emission	Tx with Tag and without Tag
Electric Field Strength of Fundamental Emission	Tx with Tag and without Tag
Spectrum Mask	Tx with Tag and without Tag
20dB Bandwidth	Tx with Tag and without Tag
Electric Field Strength of Spurious Emission	Tx with Tag and without Tag
Frequency Tolerance	Tx Mod off Mod on

Justification: The system was configured in typical fashion (as a customer would normally use it) for testing.

Frequency Tolerance:

Temperature : -30 deg.C.(minimum) to + 50deg.C.(maximum)
 (-30deg.C.: Reference, Step 10deg.C.)

Voltage : DC 5.75V, DC 4.25V (DC 5.0V ±15%)

*This EUT provides stable voltage (DC5.0V) constantly to RF Module regardless of input voltage

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SECTION 5: Conducted emission

Test Procedure and conditions

EUT was placed on a urethane platform of nominal size, 1.0m by 2.0m, raised 0.8m above the conducting ground plane. The rear of tabletop was located 40cm to the vertical conducting plane. The rear of EUT, including peripherals aligned and flushed with rear of tabletop. All other surfaces of tabletop were at least 80cm from any other grounded conducting surface. EUT was located 80cm from a Line Impedance Stabilization Network (LISN)/ Artificial mains Network (AMN) and excess AC cable was bundled in center.

For the tests on EUT with other peripherals (as a whole system)

I/O cables that were connected to the peripherals were bundled in center. They were folded back and forth forming a bundle 30cm to 40cm long and were hanged at a 40cm height to the ground plane. All unused 50ohm connectors of the LISN(AMN) were resistivity terminated in 50ohm when not connected to the measuring equipment.

The AC Mains Terminal Continuous disturbance Voltage has been measured with the EUT in a Semi Anechoic Chamber or a Measurement Room.

The EUT was connected to a LISN (AMN).

An overview sweep with peak detection has been performed.

The test results and limit are rounded off to one decimal place, so some differences might be observed.

Detector	: QP and AV
Measurement range	: 0.15-30MHz
Test data	: APPENDIX
Test result	: Pass

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SECTION 6: Radiated emission (Fundamental , Spurious Emission and Spectrum Mask)

Test Procedure

EUT was placed on a urethane platform of nominal size, 1.0m by 2.0m, raised 0.8m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane. The height of the measuring antenna varied between 1 and 4m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength. The measurements were performed for both vertical (angle of loop antenna: 0deg., 45deg., 90deg., and 135 deg.) and horizontal antenna polarization with the Test Receiver, or the Spectrum Analyzer. The measurements were made with the following detector function of the test receiver and the Spectrum analyzer (in linear mode). The test was made with the detector (RBW/VBW) in the following table. When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

Test Antennas are used as below;

Frequency	Below 30MHz	30MHz to 300MHz	300MHz to 1GHz	Above 1GHz
Antenna Type	Loop	Biconical	Logperiodic	Horn

Frequency	From 9kHz to 90kHz and From 110kHz to 150kHz	From 90kHz to 110kHz	From 150kHz to 490kHz	From 490kHz to 30MHz	From 30MHz to 1GHz	Above 1GHz	
Instrument used	Test Receiver					Spectrum Analyzer	
Detector	PK/AV	QP	PK/AV	QP	QP	PK	AV
IF Bandwidth	200Hz	200Hz	9kHz	9kHz	120kHz	RBW: 1MHz VBW: 1MHz	RBW: 1MHz VBW: 10Hz

- The carrier level and noise levels were confirmed at each position of X, Y and Z axes of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

This EUT has two transmitting modes which tag is put close to the EUT or not. The test was performed with and without tag.

* FCC Part 15 Section 15.31 (f)(2) / IC RSS-Gen 4.11 (9kHz-30MHz)

$$9\text{kHz} - 490\text{kHz} [\text{Limit at 3m}] = [\text{Limit at 300m}] - 40 \log \left(\frac{3}{300} \right)$$

$$490\text{kHz} - 30\text{MHz} [\text{Limit at 3m}] = [\text{Limit at 30m}] - 40 \log \left(\frac{3}{30} \right)$$

Measurement range : **0.09M-1GHz**

Test data : **APPENDIX**

Test result : **Pass**

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SECTION 7: Other test

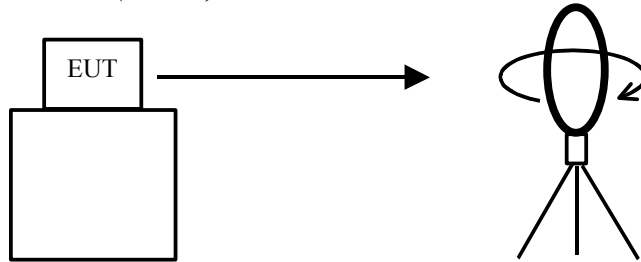
Test	Span	RBW	VBW	Sweep time	Detector	Trace	Instrument used
20dB Bandwidth	100kHz	1kHz	3kHz	Auto	Peak	Max Hold	Spectrum Analyzer
99% Occupied Bandwidth	Enough width to display 20dB Bandwidth	1 to 3% of Span	Three times of RBW	Auto	Peak	Max Hold	Spectrum Analyzer
Frequency Tolerance	-	-	-	-	-	-	Frequency counter

Test data : APPENDIX

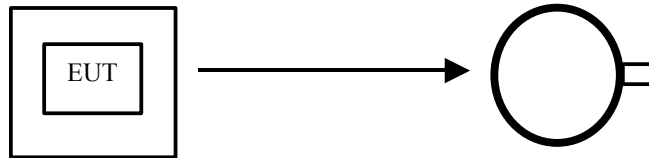
Test result : Pass

Figure 1: Direction of the Loop Antenna

Side View (Vertical)



Top View (Horizontal)



Antenna was not rotated.

Top View (Vertical)

